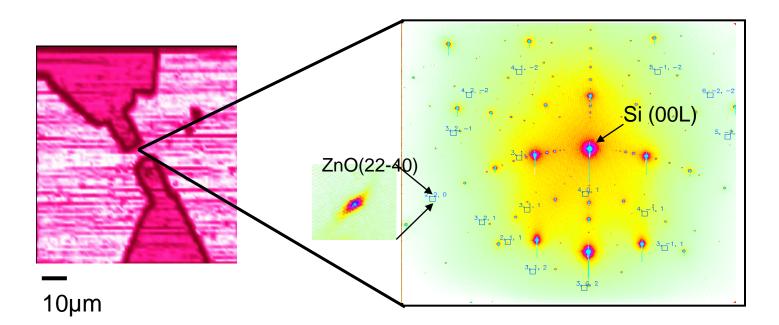
X-ray and Neutron Microdiffraction

Gene E. Ice

Materials Science and Technology Division

Oak Ridge National Laboratory



2009 Neutron X-ray Summer School



QuickTime[™] and a decompressor are needed to see this picture.

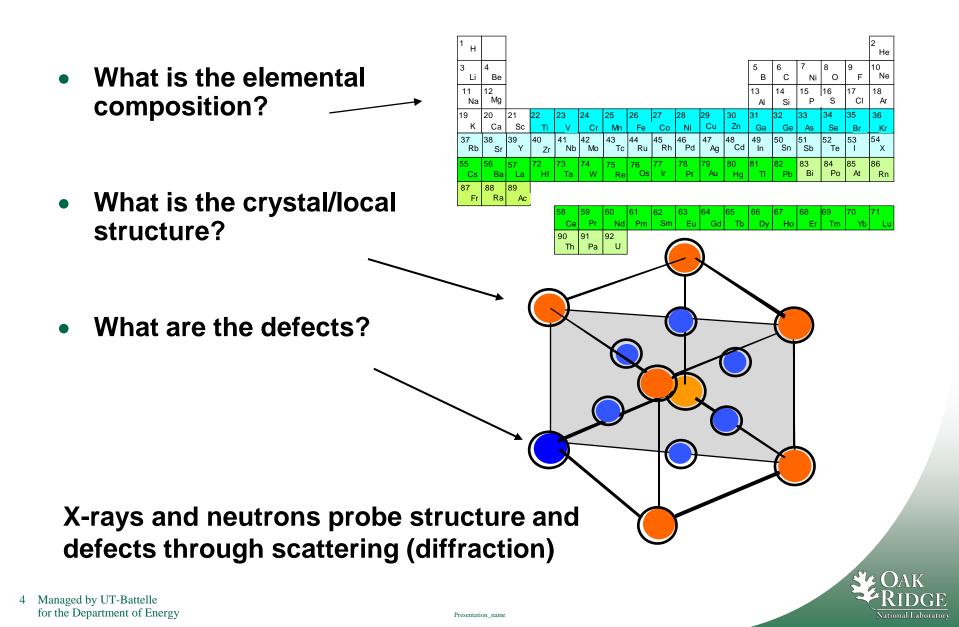


Two words

Spatial Resolution

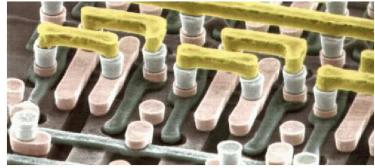


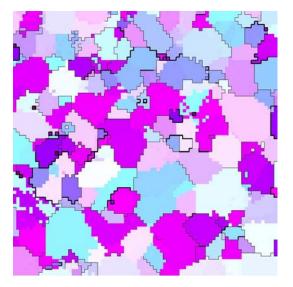
Materials characterization begins 3 questions



Spatial resolution essential!

- Most materials polycrystalline(0.1-50 μm)
 - Anisotropic
 - Heterogeneous
 - Plastic/elastic deformation/ diffusion/ oxidation/
- Even *within* single and "perfect" crystal:
 - Strain
 - Defects
 - Spontaneously organize to reduce energy









Spatial resolution essential for most advanced energy systems



QuickTime[™] and a TIFF (Uncompressed) decompressor are needed to see this picture.

QuickTime[™] and a TIFF (Uncompressed) decompressor are needed to see this picture.



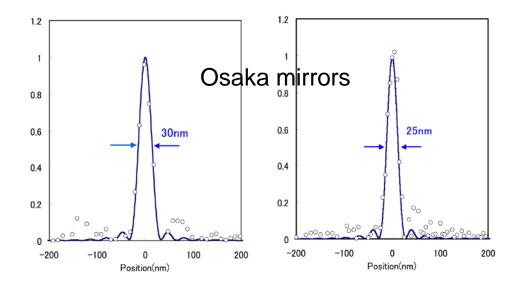
QuickTime[™] and a TIFF (Uncompressed) decompressor are needed to see this picture.

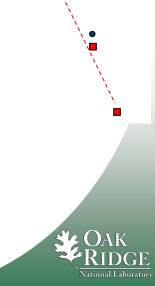


Optics improving rapidly

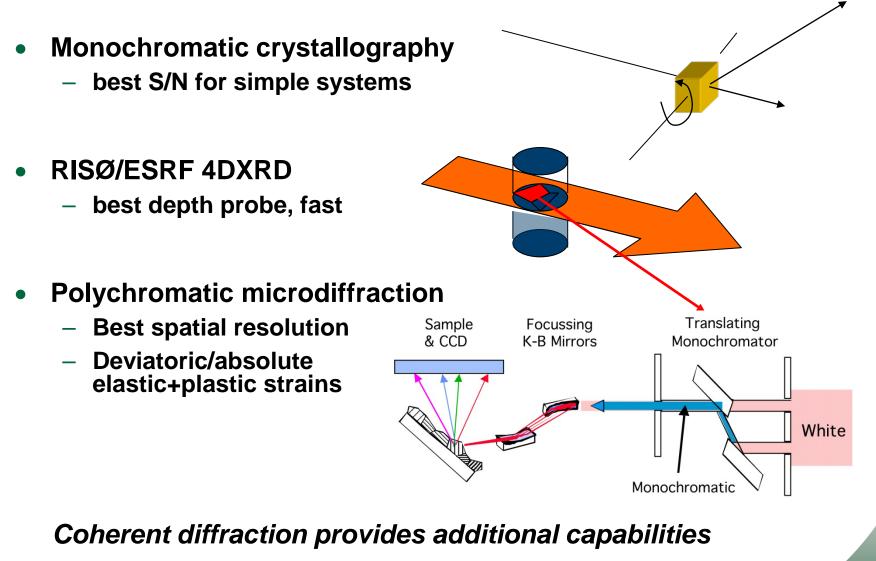
- Both chromatic and achromatic <20 nm
- New choices
 - Mirrors
 - Zone plates
 - Laue zone plates
 - Compound refractive optics

QuickTime™ and a TIFF (Uncompressed) decompressor are needed to see this picture.



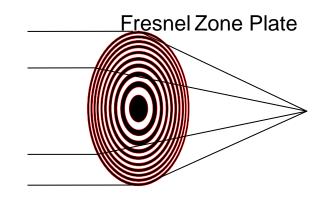


Three directions in Microdiffraction

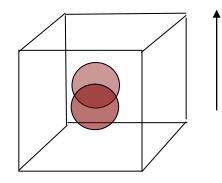




Monochromatic micro crystallography probes simple crystal systems



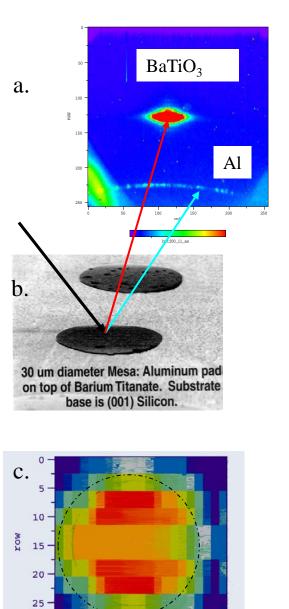
Wide-range of focusing choices



Ferroelectrics ideal samples

Thompson et al. Study domain growth/switching etc.

9 Managed by UT-Battelle for the Department of Energy



10

col

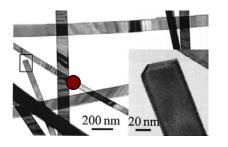
15

20

0

OAK RIDGE National Laboratory

Cai et al. and others study ultra-small nanocrystalline volumes with existing microbeams



•150 nm beam resolves crystalline substructure in individual Sn_2O_3 nanobelts 4X: 495.000 ⊕ (−0.121313, −0.0760000) N: 6.00000 @ (−0.117613, −0.0860000) 2iddf:mca1.R1 - vs X1Y Values 495.00 -0.060 \$4,500 -0.060 433.88 372.75 42.375 311.62 250.50 5.000 189.38 27.625 -0.098 128.25 20.250 -0.100 67.125 12.875 -0.1220 -0.1210 -0.1200 -0.1190 -0.1180 sample X (mm) -0.1220 -0.1210 -0.1200 -0.1190 -0.1180sample X (mm) 6.0000 5.5000 ...

Fluorescence map



Diffraction map

Synchrotron Radiation in Materials Research, Cancun, Mexico

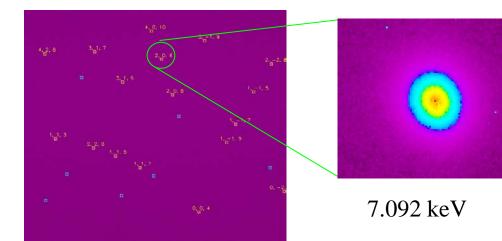
10 Managed by UT-Battelle for the Department of Energy

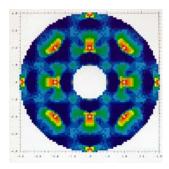
Z. Cai Presentation_name

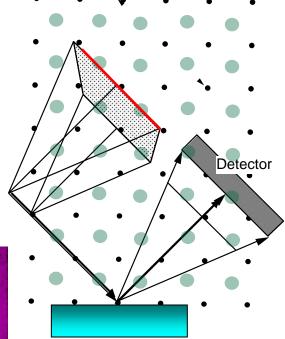
Short-range chemical order heterogeneity magnetically annealed crystal now accessible

- 6 orders of magnitude weaker than Bragg scattering
- Area detector integrates over plane in reciprocal space

11 Managed by UT-Dattene for the Department of Energy









Presentation_name

APS Nanoprobe- opens new opportunities for spatially resolved

- Diffraction proposals compelling
- Physics of small
- Integrated circuit materials



~30 nm target/ <10 nm possible in near future/ NSLSII ~1 nm!

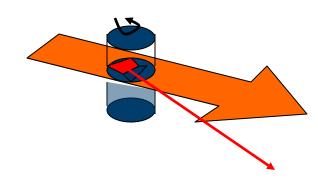


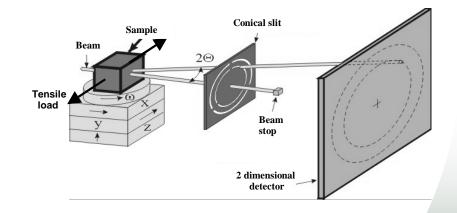
4DXRD Microscope emerging tool for studying mesoscale dynamics-single rotations

- Singly focused monobeam illuminates numerous grains
 - Bragg condition satisfied by single rotation
 - Time resolution! (4D)
- Grain outline determined
 - Ray tracing
 - conical slit
 - Back-projection tomography
- E>50 keV allows deep measurements

Best with high-energy beams/Beamline 1 at APS

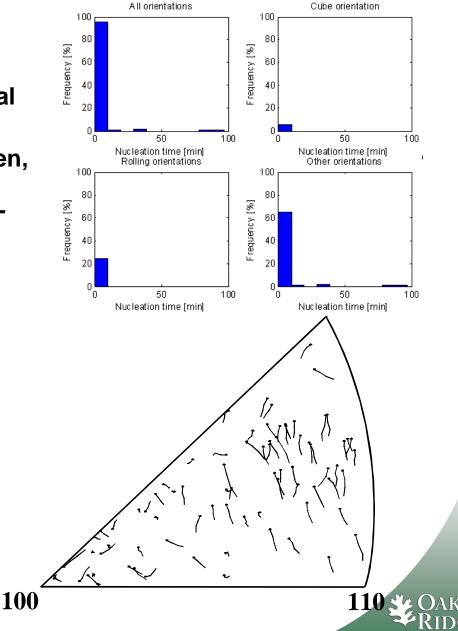






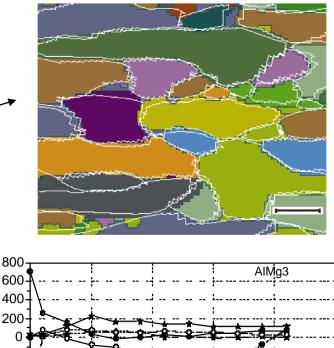
4DXRD Microscope powerful dynamics probe

- Recrystallization growth individual grains-deep
 - E. M. Lauridsen, D. Juul Jensen,
 U. Lienert and H.F. Poulsen
 (2000). Scripta Mater., 43, 561-566
- Rotations/texture evolution individual grains during deformation
 - Tests deformation models
 - L. Margulies, G. Winther and H.F. Poulsen, Science 291, 2392-2394 (2001).



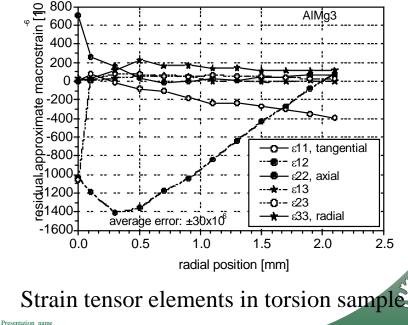
4DXRD Microscope provides additional powerful capabilities

- Grain boundary mapping in coarse grained materials-5μm
 - Poulsen et al. J. Appl. Cryst. 34 751-756 (2001)
- Single crystal refinement for polycrystals



• Macro/microstrain

Ideal for neutrons! But needs high-resolution detectors!



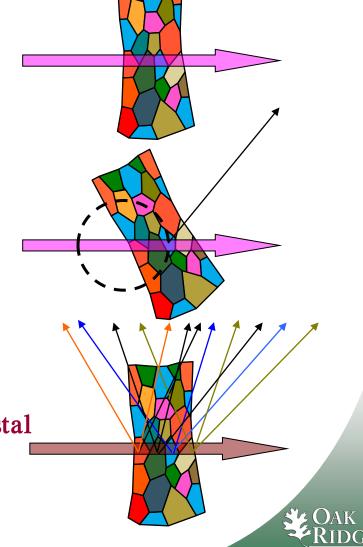
Polychromatic simplifies microdiffraction

Solves intrinsic problem with conventional microdiffraction-

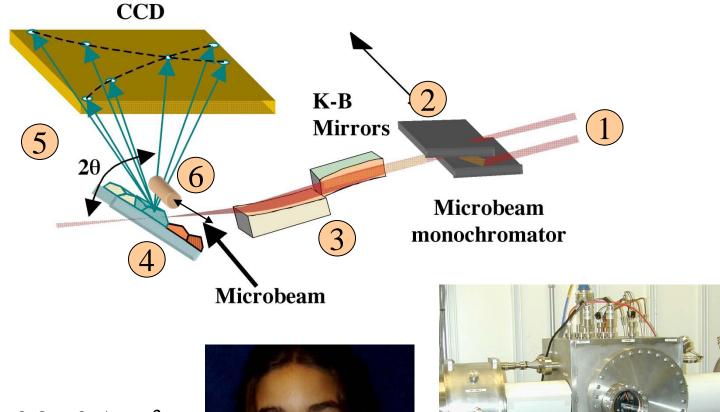
-Sample does not need to be rotated!

Special software required- Can index polycrystalline samples

3D nondestructive probe of stress/strain/crystal structure!

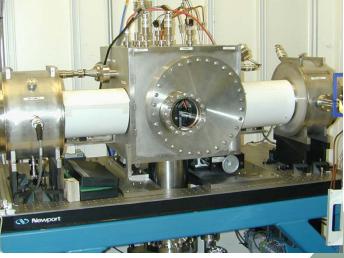


3-D X-ray Crystal Microscope has 6 key Elements



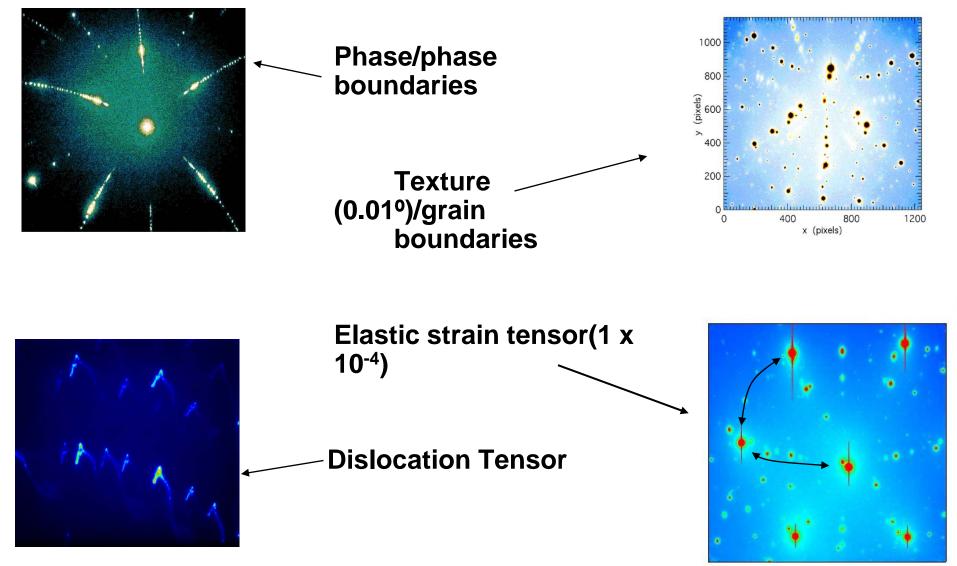
$<0.3 \text{ x } 0.3 \text{ x } 0.5 \text{ } \mu\text{m}^3$ strain~10⁻⁴-10⁻⁵







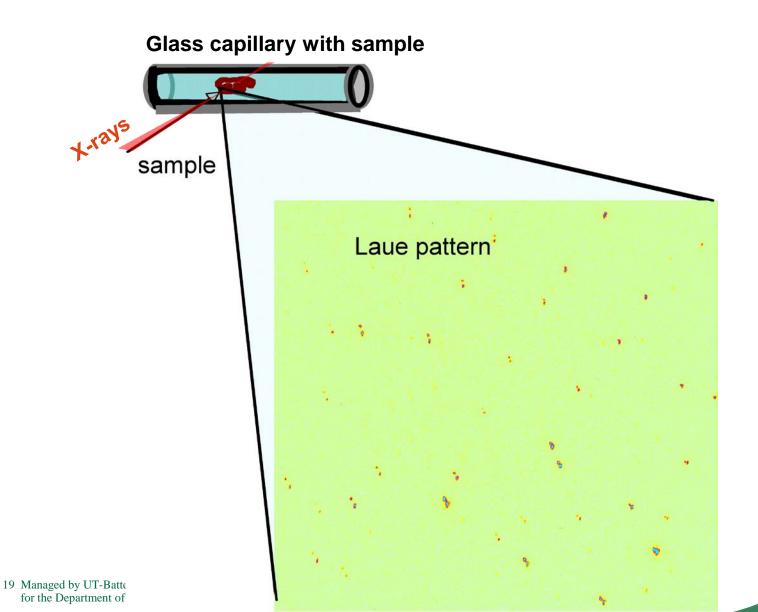
MicroLaue patterns depend on internal structure/orientation



18 Managed by UT-Battelle for the Department of Energy

National Laboratory

Laue methods essential for some samples

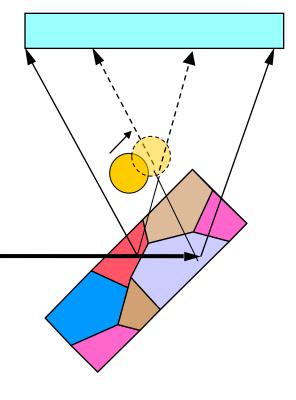




Differential aperture microscopy resolves submicron along incident beam!

- Simplifies data interpretation
- Submicron Z resolution
- Isolates weak diffraction from strong
- First demonstration by Larson et al. on deformed Cu -







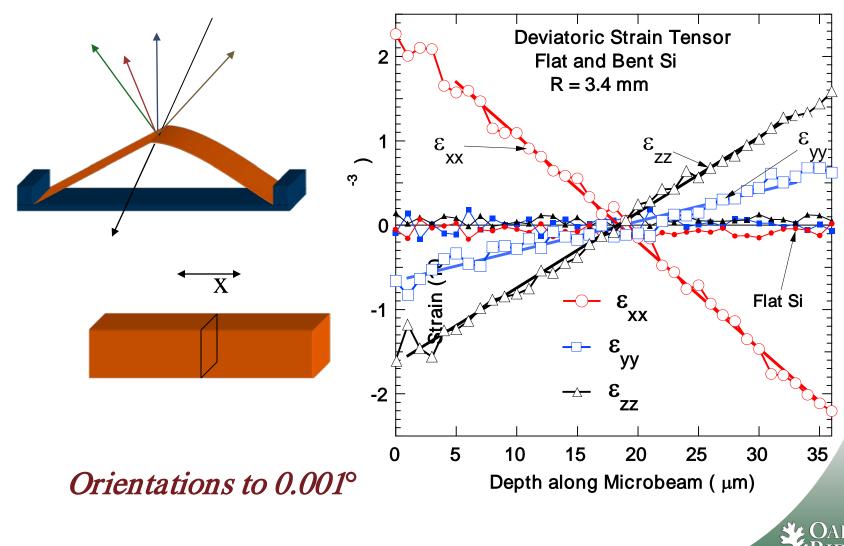
As wire moves its edge cuts through Laue spots

- Near-surface fluorescence provides moving shadow
- Long scans needed for deep penetration

QuickTime™ and a Video decompressor are needed to see this picture.

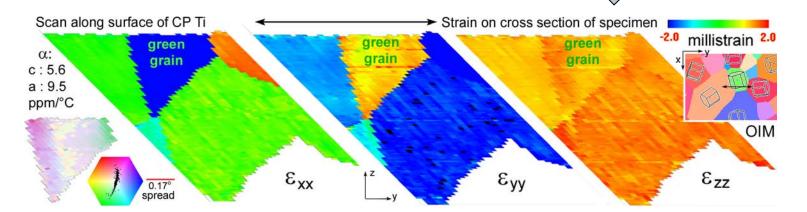


Precision measurements of strain tensor *inside* bent single crystal Si illustrate power of DAXM



Maps crystal properties in 3D

- Phase
- Texture (orientation)
- Elastic strain tensor
- Nye tensor (deformation)



T. Bieler et al.

Experimental Hutch 34ID-E at UNICAT, Advance Photon Source



differential aperture

(wire scan, ~ 200 µm above sample surface)

Sample stage

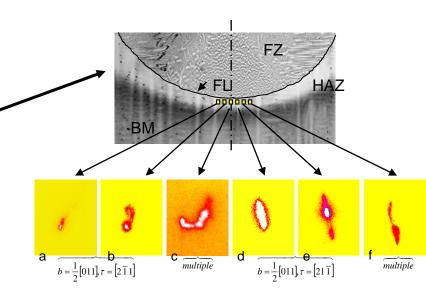
K-B Focusing mirrors

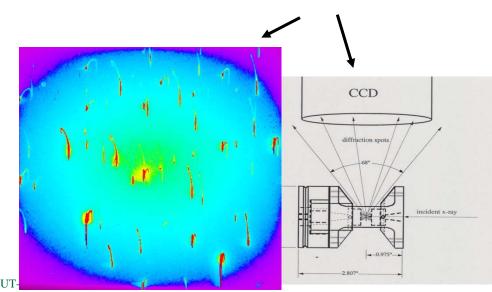




Ongoing research too extensive to cover

- Fracture/stress localization in thin films
- Residual stresses/ deformation/ grain boundary network near welds
- Complex phase patterned materials
- Extreme environmental chambers







25 Managed by UTfor the Department of Energy

Presentation_name

Ongoing too extensive continued..

- Domain wall structure measurements
- Sn whisker growth
- High-performance alloys
- Nanomaterials

[0,0,1] Sample Orientation Mapping +700 nm 0 -400 nm

10µm

Energy scans allow structure determination

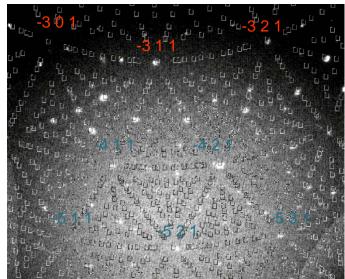
 Generalization of orientation software can identify phases

QuickTimeý Dz TIFFÅiàèkǻǵÅj êLí£Év ÉçÉOÉâÉÄ ǙDZÇÃÉsÉNÈ`ÉÉǾå©ÇÈǞǽÇ...ÇÕïKóvÇ-Ç..

- Energy scans provide integrated reflectivities.
- Identified two minor crystal phases tetragonal/hexagonal

Cannot be found by powder

BAM braze $Pd_{40}Cu_{30}Ni_{10}P_{20}$

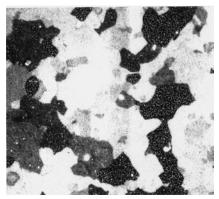


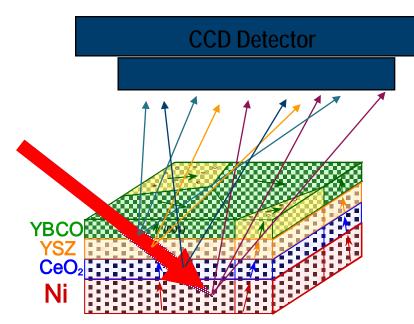




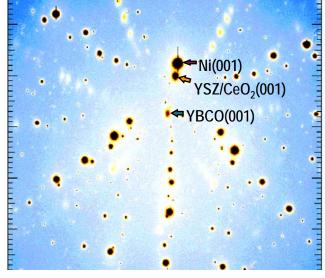
Grain-growth/ Budai et al. characterized epitaxial growth RABiTS

Optical: ~50µm grains





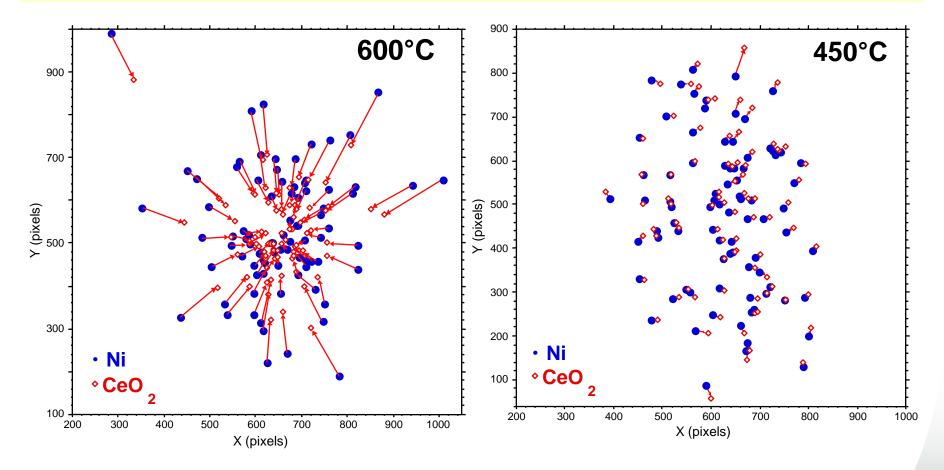
CCD Laue Patterns



<u>CeO₂ Observation</u>: Exact epitaxy for growth at low T; lattice tilts at high T



Relative CeO₂orientation depends deposition temperature



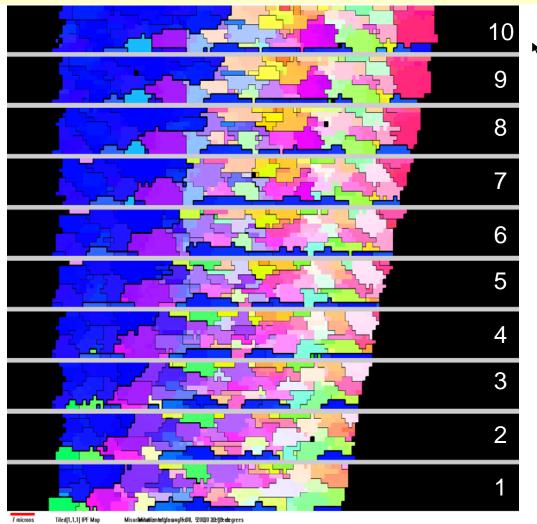
Step edge growth- good: Crystallographic tilt towards ⊥

Tilt increases monotonically with miscut

Island growth-bad:



In-situ observations of 3D Grain Growth

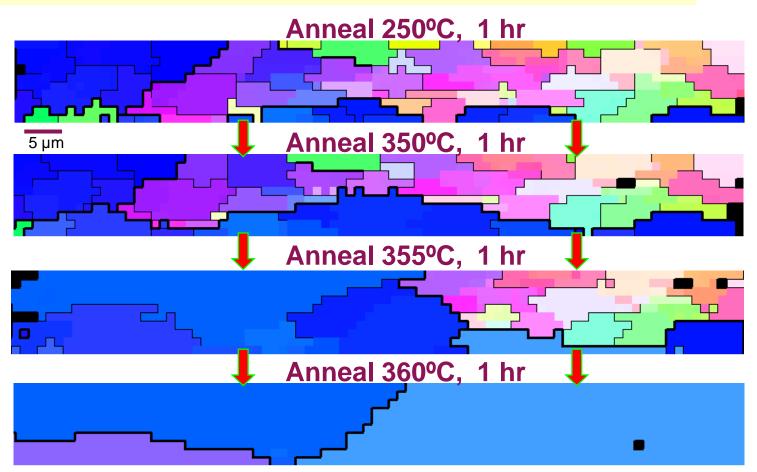


Hot-rolled (200°C 1xxx Al(~1%Fe,Si) Alcoa Polycrystal



Thermal Grain Growth in Hot-Rolled Aluminum

1 µm pixels, Boundaries: 5° & 20°

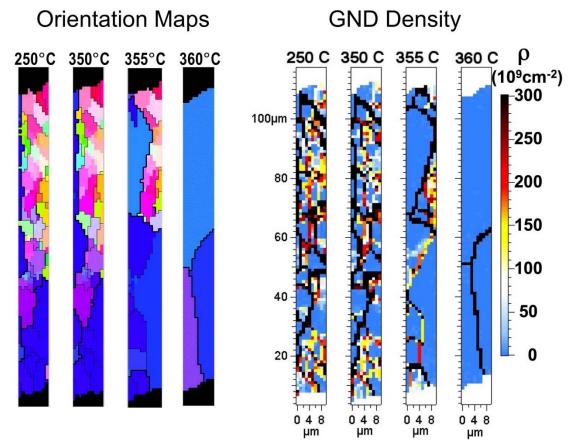


GB motions include both high-angle and low-angle boundaries

• Complete and detailed 3D evolution needed for validation of theories.

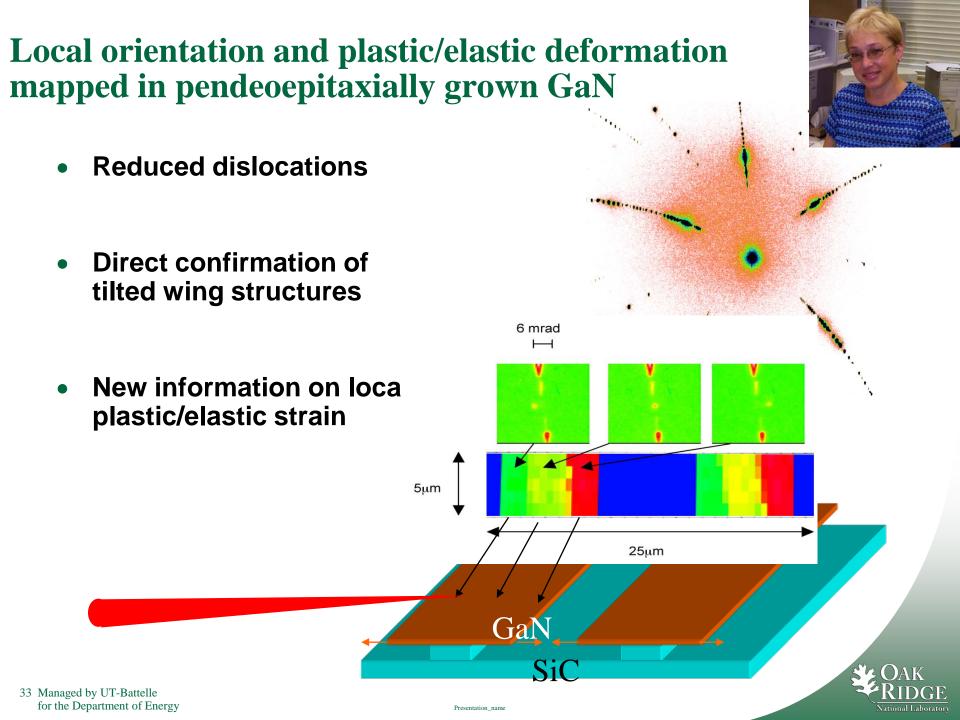


Thermal Grain-Growth And Microstructure Refinement in Polycrystalline Al



 3D X-ray Microscopy Measurements of Dislocation Density Finds Microstructure Refinement to Be Important





Spatial resolution critical photovoltaics

- Chemical/ structural defects important
- Surfaces/Interfaces critical
- Novel materials depend on dimensionality

QuickTime[™] and a TIFF (Uncompressed) decompressor are needed to see this picture.

McHugo et al. ALS 1997 Chemical defect influence on Solar Cells

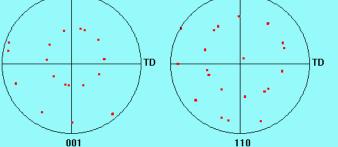


"Semicrystalline" Silicon for Cost-Effective Solar Cells

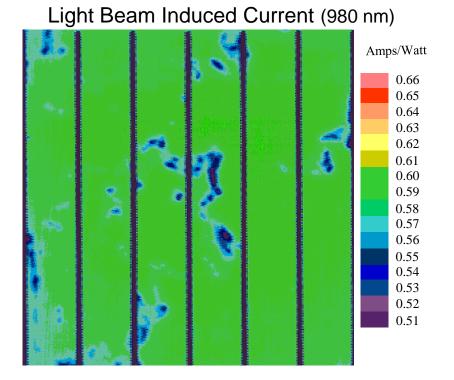
Collaboration between ORNL and Georgia Inst. of Technology

Correlate photovoltaic efficiency with local orientation and microstructure

X-ray Microdiffraction Si(001) Orientation 1800 microns [0,0,1] Sample Orientation Mapping 2.5mm



35 Managed by UT-Battelle for the Department of Energy

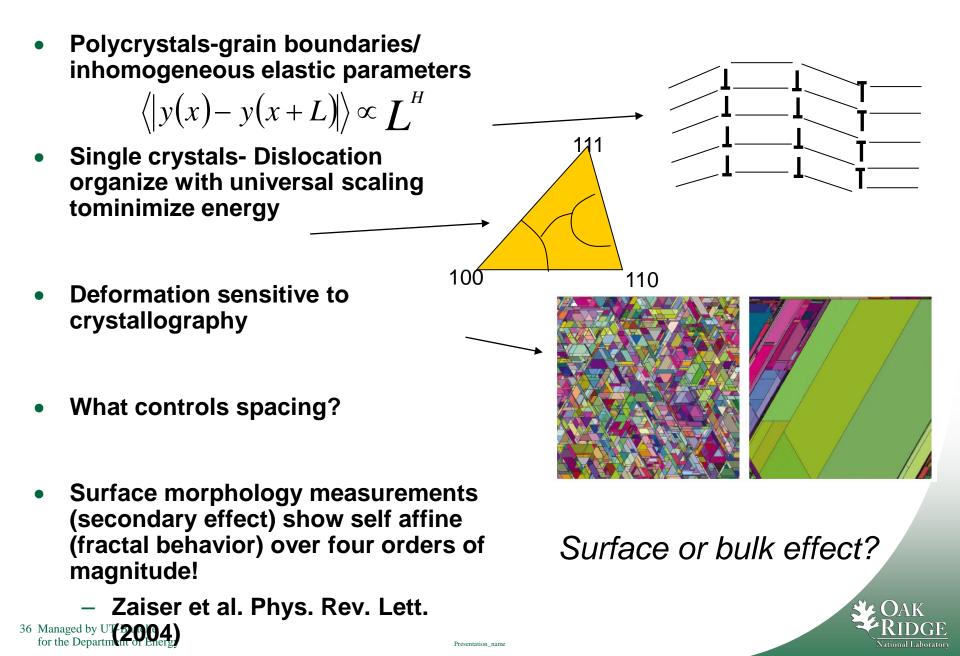


- •Pole figures: Strong (110) fiber texture
- •Goal: Understand and control structural origins of PV efficiency.

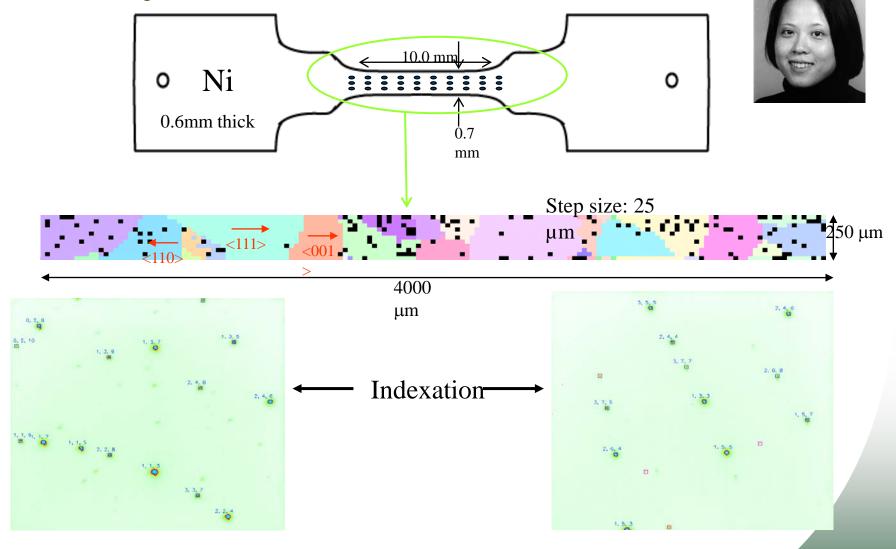


Presentation_name

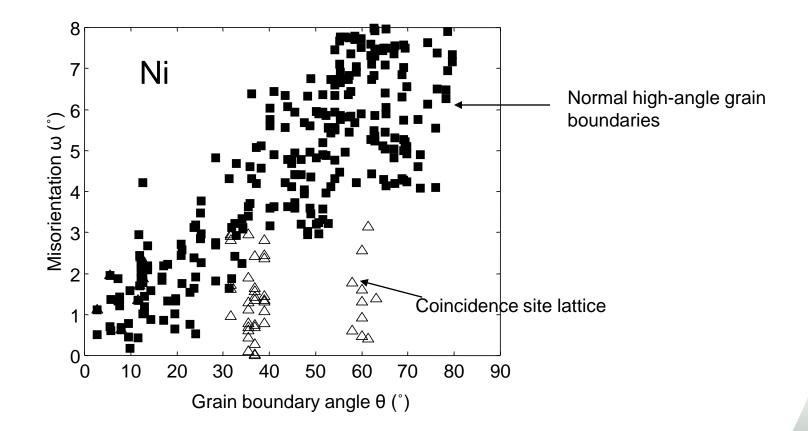
Deformation complicated



Deformation in polycrystals illustrates grain boundary behavior



Deformation induced rotations across grain boundaries sensitive to boundary type



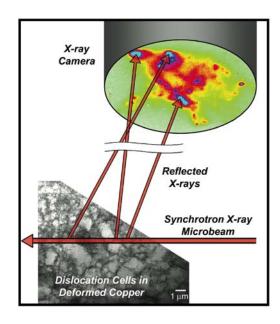


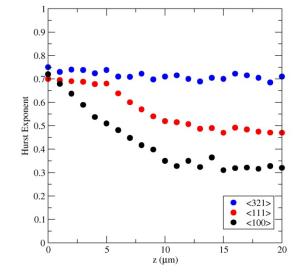
New information about deformation

Near surfaces and interfaces

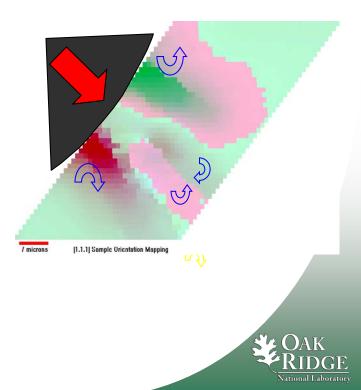
In single and polycrystals

 Organization dynamics of defects (Krivoglaz defects of 2nd kind)



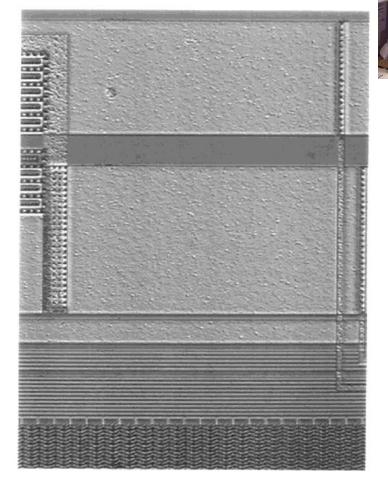


Lattice Rotation Map



Deformation found during electromigration

- Device reliability linked to electromigration-MA/cm²
- Theories assume stress development opposses mass transport
- Need to measure stress drove development of polychromatic microdiffraction

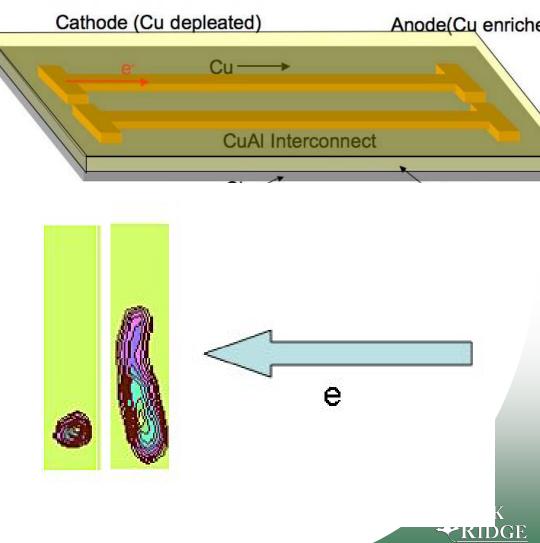


R. I Barabash et al. J. Appl. Phys 93 5701 (2003).

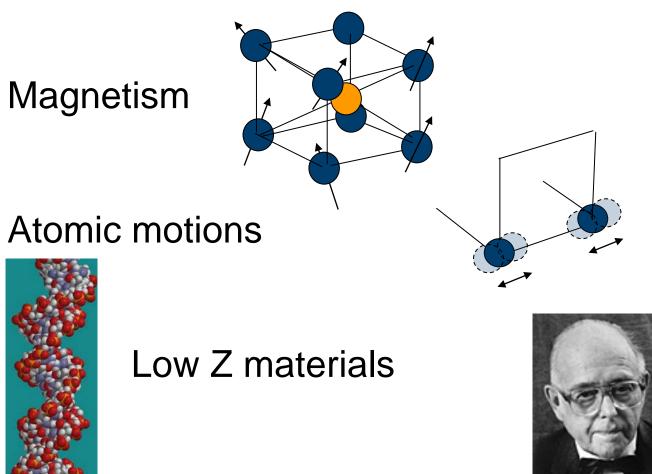


AI (Cu) interconnects studied

- Deformation big grains.
- Small grains rotate.
- Deformation preceded Cu diffusion
- Unpaired dislocations develop parallel to the electrical field.
- Little dislocation activity near the anode end of the wire (Cu enhanced).



Neutron analog additional opportunities





Nobel prize to Shull and Brockhouse

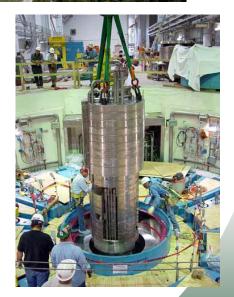


Even the most intense neutron source must be used efficiently

Neutron sources 10¹² lower brilliance than advanced x-ray

Neutrons expensive 10¹³ more expensive!

10⁻¹⁶\$ /x-ray 10⁻³\$ /neutron Increase divergence/bandpass 10⁻⁹\$/ neutron

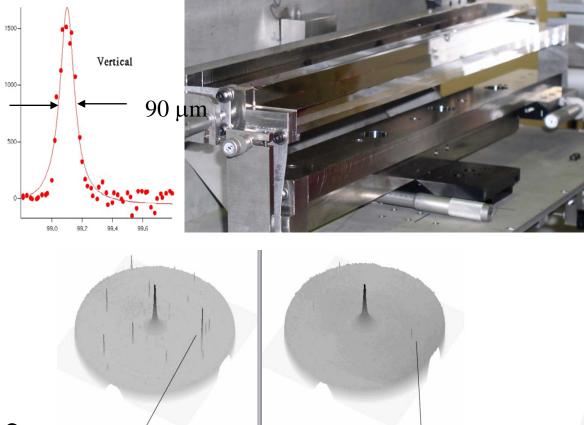


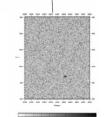


Neutron mirrors produce microbeams

- Better signal-to-noise
- Resolve inhomogeneities
- Map crystal distributions

Useable 25 μ m beams?





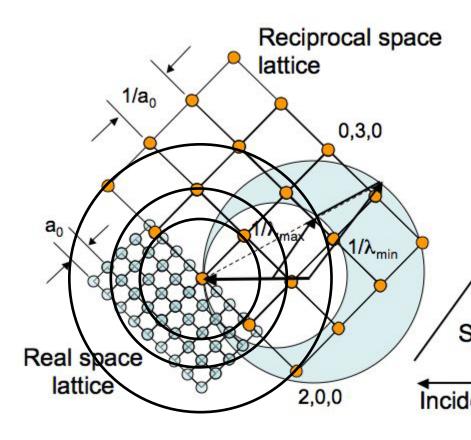


Spallation neutron science intrinsically polychromatic

 Analogous to polychromatic X-ray microdiffraction-but includes energy

• Allows for structure determination

 Absolute strain measurements





Will extend neutron science

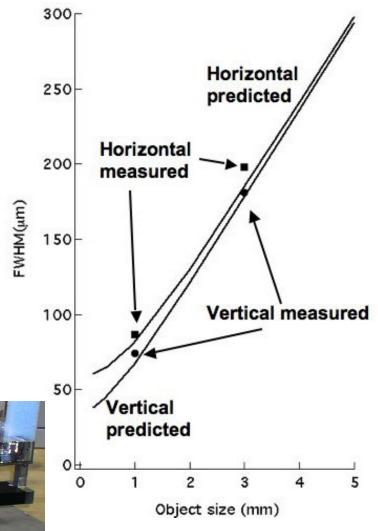
- Inhomogeneous samples
- Small samples in environmental chambers



SNAP experiments diffraction high pressure cells

• Focusing optics work near theoretical limit

 Minor improvements should enable 25 micron measurements





Conclusion: Microdiffraction

- Addresses long-standing issues materials physics
- Techniques and instrumentation rapidly evolving
- Answers specific questions about materials systems (Energy materials)
- Extend x-ray and neutron characterization to new classes of samples.
 - Dangerous
 - Inhomogeneous
 - Samples in extreme environments



Advanced materials structures- intrinsically 3D And spatial resolution- is needed urgently X-ray and neutron beams- can penetrate to see Materials crystal structures- and heterogeneity

CHORUS

Nondispersive - optics change what we can see Mesostructure- resolved by crystallography Atomic defects quantified - so that we can surmise Emergent structures origins- at the mesoscopic size

New optics and new methods- extend what we can do With spatial resolution- time resolution too Nondestructive lets us watch- materials deep inside Chambers or complex system - where once they could hide

Emerging applications- I've tried to show a few Energy materials- have challenges quite new With x-ray and neutron beams- we now are freed To study these materials- on the scale that we need

